

Search Notes

Application/Control No.

10/677,370

Examiner

Lamson D. Nguyen

Applicant(s)/Patent under
Reexamination

TAKAHASHI ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR